

Notice of References Cited	Application/Control No. 09/941,142	Applicant(s)/Patent Under Reexamination WAH CHAN ET AL.	
	Examiner DAVID J. HUISMAN	Art Unit 2183	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,212,622	04-2001	Witt, David B.	712/216
	B	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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